Form PTO 1449	U.S. DEPARTMENT OF COMMERCE			ATTY DOCKET NO.		SERIAL NO.		
(Modified)		PATENT AND TRAC	DEMARK OFFICE	249971US6CONT		NEW APPLICATION		
				APPLICANT				
LIST OF	REFE	RENCES CITED BY AP	PLICANT	Erich BAYER				
				FILING DATE		GROUP .		
				HEREWITH				
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
	AX							
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	AZ	1 Ada				ditional References sheet(s) attached		
Examiner		14 4	X-		Date Considered 3/13/07			
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.								